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Jameco Part Number 670653

11A, 200V, 0.500 Ohm, P-Channel Power MOSFETs

These are P-Channel enhancement mode silicon-gate power field-effect transistors. They are advanced power MOSFETs designed, tested, and guaranteed to withstand a specified level of energy in the breakdown avalanche mode of operation. All of these power MOSFETs are designed for applications such as switching regulators, switching converters, motor drivers, relay drivers and as drivers for other high-power switching devices. The high input impedance allows these types to be operated directly from integrated circuits.

Formerly developmental type TA17522.

Ordering Information

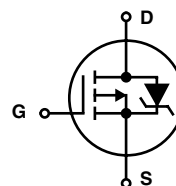
PART NUMBER	PACKAGE	BRAND
IRF9640	TO-220AB	IRF9640
RF1S9640SM	TO-263AB	RF1S9640

NOTE: When ordering, use the entire part number. Add the suffix 9A to obtain the TO-263AB variant in the tape and reel, i.e., RF1S9640SM9A.

Features

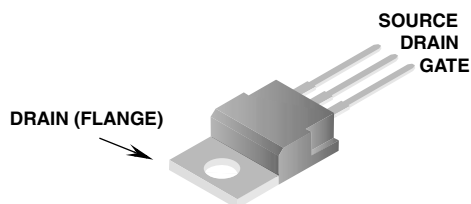
- 11A, 200V
- $r_{DS(ON)} = 0.500\Omega$
- Single Pulse Avalanche Energy Rated
- SOA is Power Dissipation Limited
- Nanosecond Switching Speeds
- Linear Transfer Characteristics
- High Input Impedance
- Related Literature
 - TB334, "Guidelines for Soldering Surface Mount Components to PC Boards"

Symbol

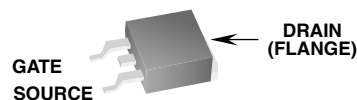


Packaging

JEDEC TO-220AB



JEDEC TO-263AB



IRF9640, RF1S9640SM

Absolute Maximum Ratings $T_C = 25^\circ\text{C}$, Unless Otherwise Specified

	IRF9640, RF1S9640SM	UNITS
Drain to Source Breakdown Voltage (Note 1)	V_{DS}	-200 V
Drain to Gate Voltage ($R_{GS} = 20\text{k}\Omega$) (Note 1)	V_{DGR}	-200 V
Continuous Drain Current	I_D	-11 A
$T_C = 100^\circ\text{C}$	I_D	-7 A
Pulsed Drain Current (Note 2)	I_{DM}	-44 A
Gate to Source Voltage	V_{GS}	± 20 V
Maximum Power Dissipation	P_D	125 W
Linear Derating Factor		1 $W/^\circ\text{C}$
Single Pulse Avalanche Energy Rating (Note 3, 4)	E_{AS}	790 mJ
Operating and Storage Temperature	T_J, T_{STG}	-55 to 150 $^\circ\text{C}$
Maximum Temperature for Soldering		
Leads at 0.063in (1.6mm) from Case for 10s.	T_L	300 $^\circ\text{C}$
Package Body for 10s, See Techbrief 334	T_{pkg}	260 $^\circ\text{C}$

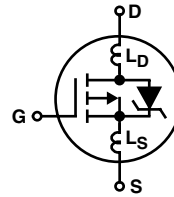
CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

NOTE:

1. $T_J = 25^\circ\text{C}$ to 125°C

Electrical Specifications $T_C = 25^\circ\text{C}$, Unless Otherwise Specified

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNITS
Drain to Source Breakdown Voltage	BV_{DSS}	$I_D = -250\mu\text{A}$, $V_{GS} = 0\text{V}$ (Figure 10)	-200	-	-	V
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{GS} = V_{DS}$, $I_D = -250\mu\text{A}$	-2	-	-4	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = \text{Rated } BV_{DSS}$, $V_{GS} = 0\text{V}$	-	-	25	μA
		$V_{DS} = 0.8 \times \text{Rated } BV_{DSS}$, $V_{GS} = 0\text{V}$, $T_C = 125^\circ\text{C}$	-	-	250	μA
On-State Drain Current (Note 2)	$I_{D(ON)}$	$V_{DS} > I_{D(ON)} \times r_{DS(ON)MAX}$, $V_{GS} = -10\text{V}$	-11	-	-	A
Gate to Source Leakage Current	I_{GSS}	$V_{GS} = \pm 20\text{V}$	-	-	± 100	nA
Drain to Source On Resistance (Note 2)	$r_{DS(ON)}$	$I_D = -6\text{A}$, $V_{GS} = -10\text{V}$ (Figures 8, 9)	-	0.350	0.500	Ω
Forward Transconductance (Note 2)	g_{fs}	$V_{DS} > I_{D(ON)} \times r_{DS(ON)MAX}$, $I_D = -6\text{A}$ (Figure 12)	4	6	-	S
Turn-On Delay Time	$t_{d(ON)}$	$V_{DD} = 0.5 \times \text{Rated } BV_{DSS}$, $I_D \approx -11\text{A}$, $R_G = 9.1\Omega$	-	18	22	ns
Rise Time	t_r	$V_{GS} = -10\text{V}$ (Figures 17, 18)	-	45	68	ns
Turn-Off Delay Time	$t_{d(OFF)}$	$R_L = 8.4\Omega$ for $V_{DSS} = -100\text{V}$	-	75	90	ns
Fall Time	t_f	$R_L = 6.1\Omega$ for $V_{DSS} = -75\text{V}$	-	29	44	ns
Total Gate Charge (Gate to Source + Gate to Drain)	$Q_{g(TOT)}$	MOSFET Switching Times are Essentially Independent of Operating Temperature	-	70	90	ns
Gate to Source Charge	Q_{gs}	$V_{GS} = -10\text{V}$, $I_D = -11\text{A}$, $V_{DS} = 0.8 \times \text{Rated } BV_{DSS}$	-	55	-	nC
Gate to Drain "Miller" Charge	Q_{gd}	$I_{g(REF)} = -1.5\text{mA}$ (Figures 14, 19, 20)	-	15	-	nC
Input Capacitance	C_{ISS}	Gate Charge is Essentially Independent of Operating Temperature	-	1100	-	pF
Output Capacitance	C_{OSS}	$V_{DS} = -25\text{V}$, $V_{GS} = 0\text{V}$, $f = 1\text{MHz}$	-	375	-	pF
Reverse Transfer Capacitance	C_{RSS}	(Figure 11)	-	150	-	pF
Internal Drain Inductance	L_D	Measured From the Contact Screw on Tab To Center of Die	-	3.5	-	nH
		Measured From the Drain Lead, 6mm (0.25in) from Package to Center of Die	-	4.5	-	nH
Internal Source Inductance	L_S	Measured From the Source Lead, 6mm (0.25in) from Header to Source Bonding Pad	-	7.5	-	nH
Thermal Resistance Junction to Case	$R_{\theta JC}$		-	-	1.0	$^\circ\text{C/W}$
Thermal Resistance Junction to Ambient	$R_{\theta JA}$	Typical Socket Mount	-	-	62.5	$^\circ\text{C/W}$



Source to Drain Diode Specifications

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNITS
Continuous Source to Drain Current	I_{SD}	Modified MOSFET Symbol Showing the Integral Reverse P-N Junction Diode	-	-	-11	A
Pulse Source to Drain Current (Note 3)	I_{SDM}		-	-	-44	A
Source to Drain Diode Voltage (Note 2)	V_{SD}	$T_J = 25^{\circ}\text{C}$, $I_{SD} = -11\text{A}$, $V_{GS} = 0\text{V}$ (Figure 13)	-	-	-1.5	V
Reverse Recovery Time	t_{rr}	$T_J = 150^{\circ}\text{C}$, $I_{SD} = -11\text{A}$, $dI_{SD}/dt = 100\text{A}/\mu\text{s}$	-	300	-	ns
Reverse Recovery Charge	Q_{RR}	$T_J = 150^{\circ}\text{C}$, $I_{SD} = -11\text{A}$, $dI_{SD}/dt = 100\text{A}/\mu\text{s}$	-	1.9	-	μC

NOTES:

- Pulse Test: Pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$.
- Repetitive Rating: Pulse width limited by Max junction temperature. See Transient Thermal Impedance curve (Figure 3).
- $V_{DD} = 50\text{V}$, starting $T_J = 25^{\circ}\text{C}$, $L = 9.8\text{mH}$, $R_G = 25\Omega$, peak $I_{AS} = 11\text{A}$. See Figures 15, 16.

Typical Performance Curves Unless Otherwise Specified

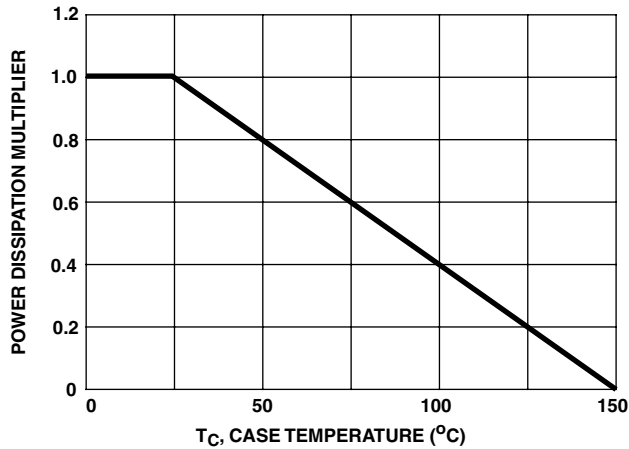


FIGURE 1. NORMALIZED POWER DISSIPATION vs CASE TEMPERATURE

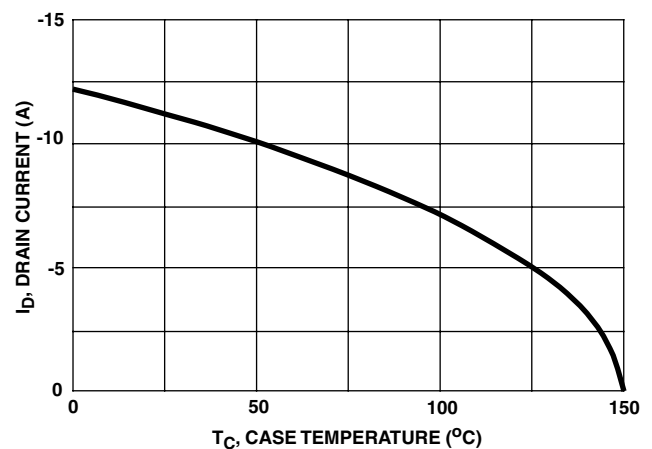


FIGURE 2. MAXIMUM CONTINUOUS DRAIN CURRENT vs CASE TEMPERATURE

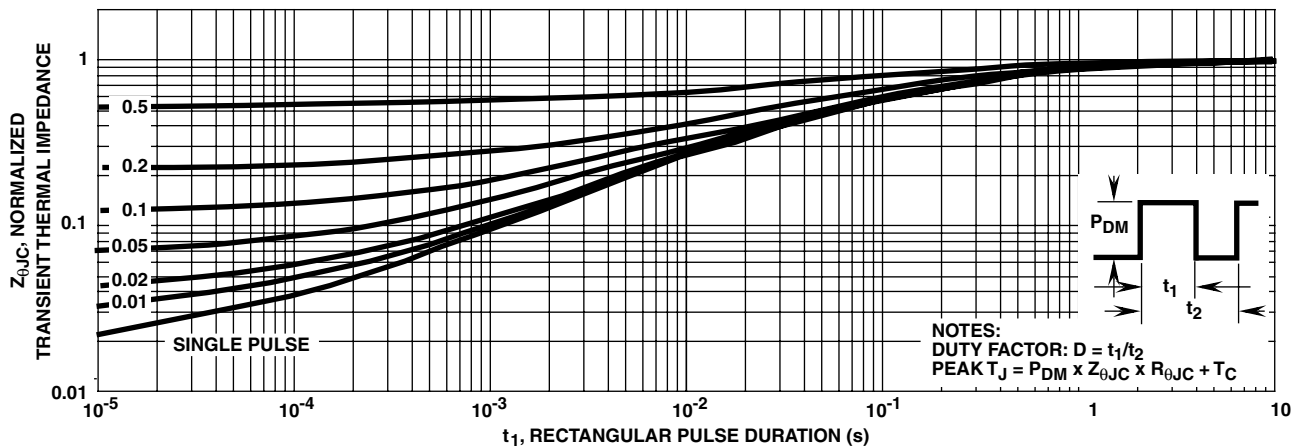


FIGURE 3. MAXIMUM TRANSIENT THERMAL IMPEDANCE

Typical Performance Curves Unless Otherwise Specified (Continued)

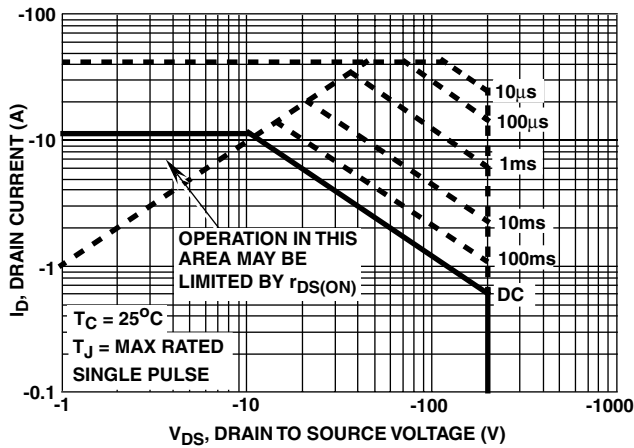


FIGURE 4. FORWARD BIAS SAFE OPERATING AREA

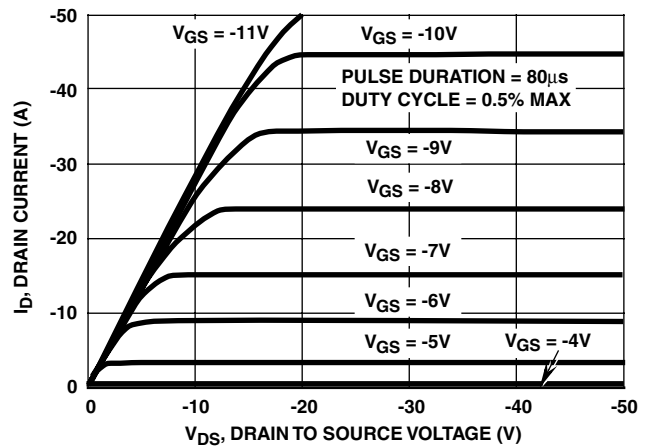


FIGURE 5. OUTPUT CHARACTERISTICS

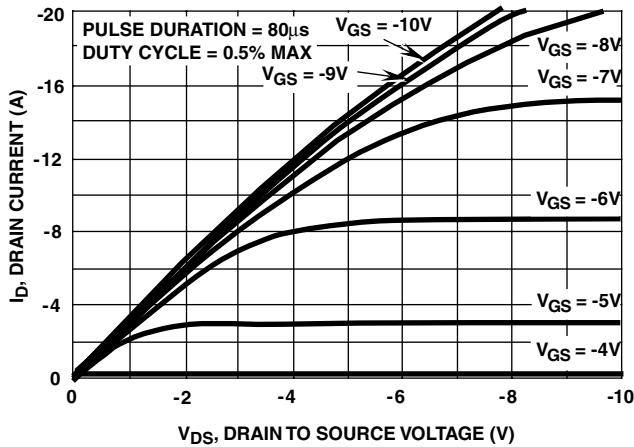


FIGURE 6. SATURATION CHARACTERISTICS

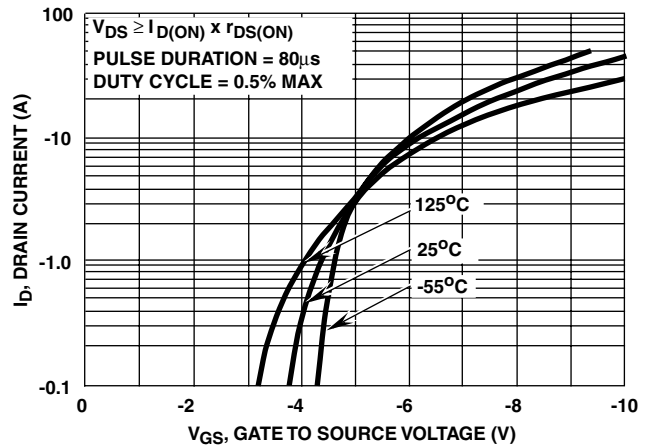
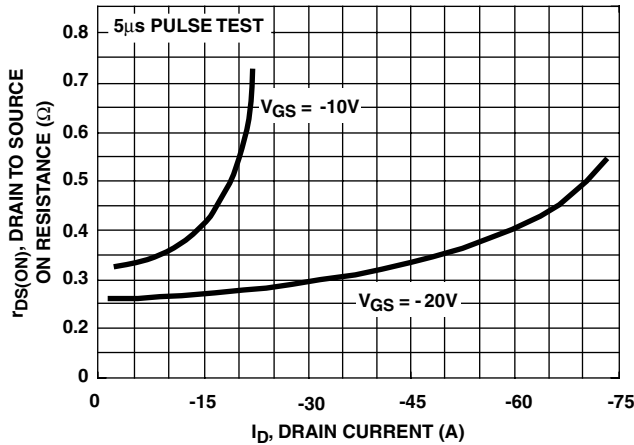


FIGURE 7. TRANSFER CHARACTERISTICS



NOTE: Heating effect of 5µs pulse is minimal.

FIGURE 8. DRAIN TO SOURCE ON RESISTANCE vs. GATE VOLTAGE AND DRAIN CURRENT

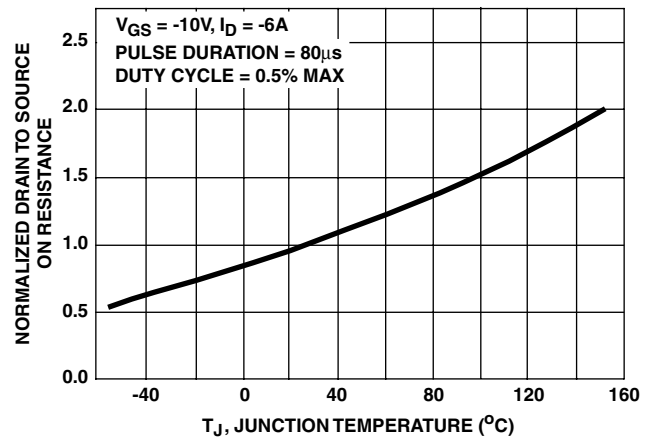


FIGURE 9. NORMALIZED DRAIN TO SOURCE ON RESISTANCE vs. JUNCTION TEMPERATURE

Typical Performance Curves Unless Otherwise Specified (Continued)

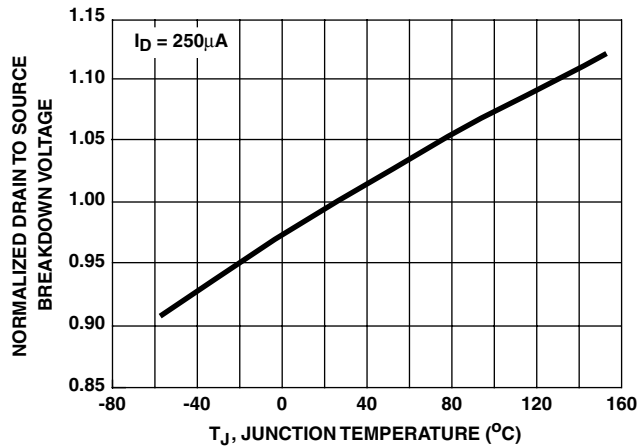


FIGURE 10. NORMALIZED DRAIN TO SOURCE BREAKDOWN VOLTAGE vs JUNCTION TEMPERATURE

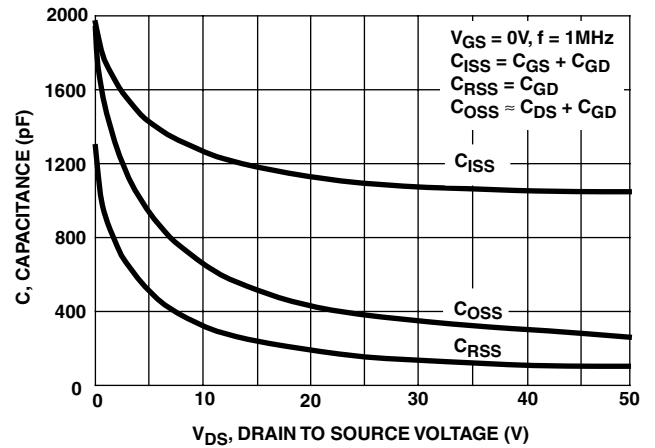


FIGURE 11. CAPACITANCE vs DRAIN TO SOURCE VOLTAGE

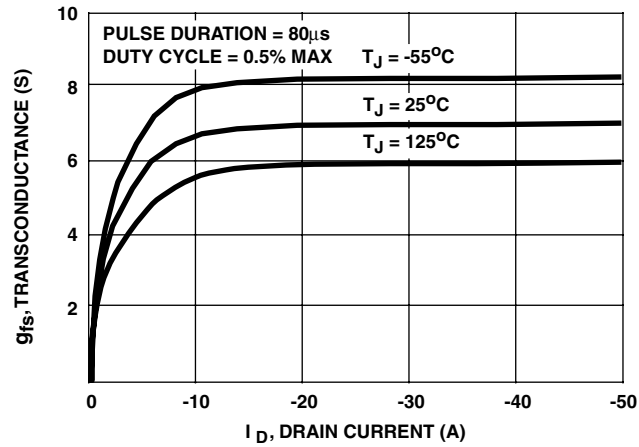


FIGURE 12. TRANSCONDUCTANCE vs DRAIN CURRENT

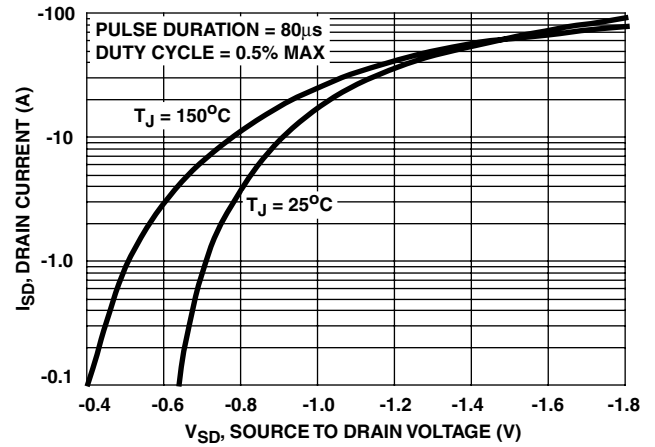


FIGURE 13. SOURCE TO DRAIN DIODE VOLTAGE

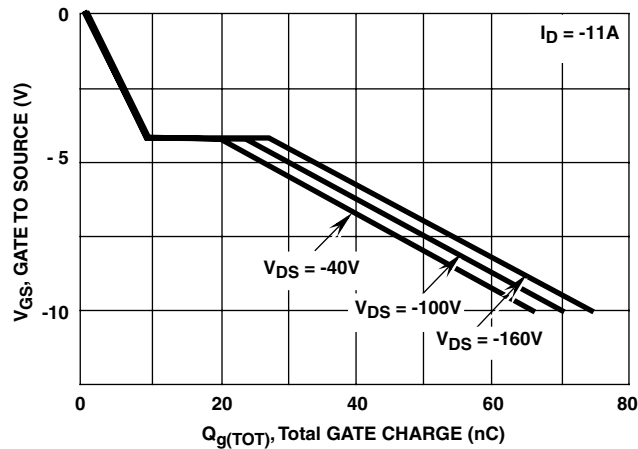


FIGURE 14. GATE TO SOURCE VOLTAGE vs GATE CHARGE

Test Circuits and Waveforms

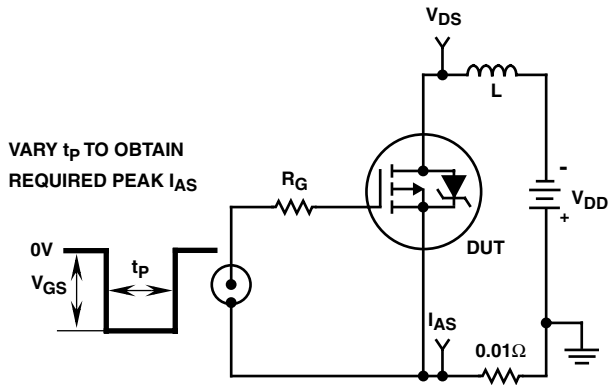


FIGURE 15. UNCLAMPED ENERGY TEST CIRCUIT

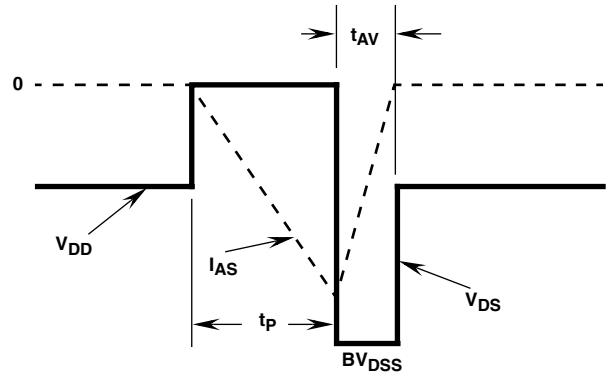


FIGURE 16. UNCLAMPED ENERGY WAVEFORMS

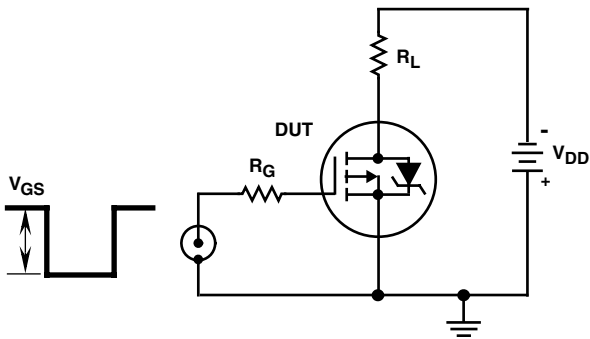


FIGURE 17. SWITCHING TIME TEST CIRCUIT

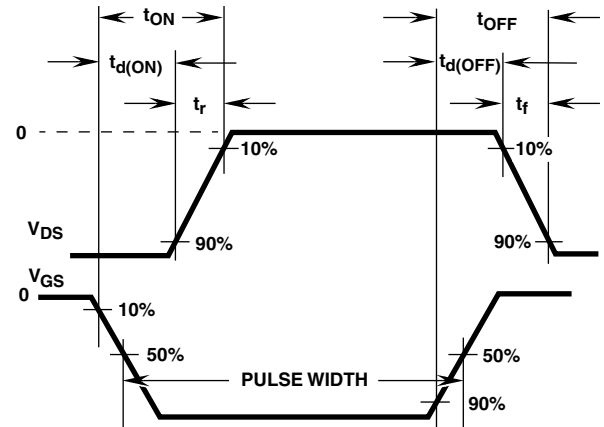


FIGURE 18. RESISTIVE SWITCHING WAVEFORMS

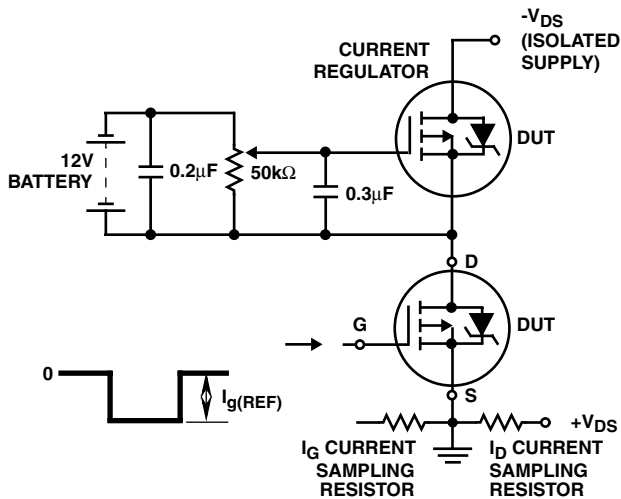


FIGURE 19. GATE CHARGE TEST CIRCUIT

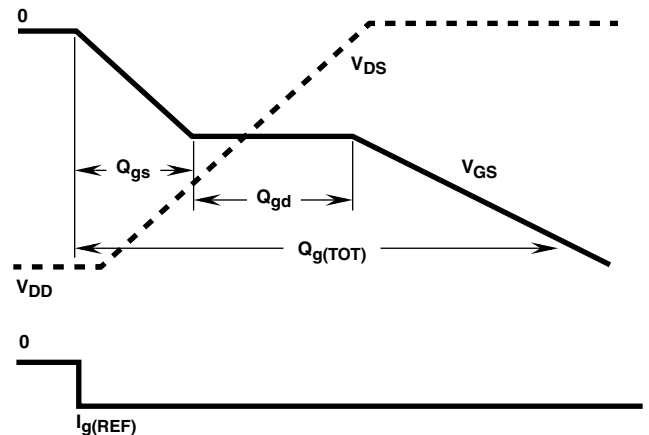


FIGURE 20. GATE CHARGE WAVEFORMS

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2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

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